

**Search Notes**

Application/Control No.

10/713,627

Examiner

Duc M. Nguyen

Applicant(s)/Patent under  
Reexamination

KARR ET AL.

Art Unit

2685

**SEARCHED**

Class	Subclass	Date	Examiner
455	550 552.1 553.1		
	556.1		
	557 41.1		
	41.2 41.3		
	515 102		
	108 110		
	115.1		
	115.3		
	161.1		
	161.3		
	226.2		
	205 208		
	334	2/28/2006	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR